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March 2015

# FCD3400N80Z / FCU3400N80Z

## N-Channel SuperFET<sup>®</sup> II MOSFET

800 V, 2 A, 3.4 Ω

### Features

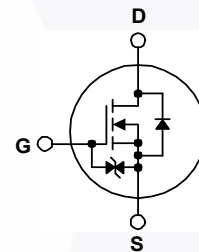
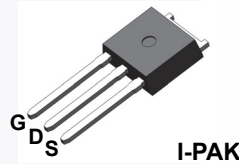
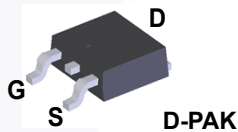
- $R_{DS(on)} = 2.75 \Omega$  (Typ.)
- Ultra Low Gate Charge (Typ.  $Q_g = 7.4$  nC)
- Low  $E_{oss}$  (Typ. 0.9 uJ @ 400V)
- Low Effective Output Capacitance (Typ.  $C_{oss(eff.)} = 41$  pF)
- 100% Avalanche Tested
- RoHS Compliant
- ESD Improved Capability

### Applications

- AC - DC Power Supply
- LED Lighting

### Description

SuperFET<sup>®</sup> II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as Audio, Laptop adapter, Lighting, ATX power and industrial power applications.



### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted.

| Symbol         | Parameter  | FCD3400N80Z<br>FCU3400N80Z                 | Unit             |
|----------------|--|--|------------------|
| $V_{DSS}$      | Drain to Source Voltage  | 800  | V                |
| $V_{GSS}$      | Gate to Source Voltage   | - DC                                       | $\pm 20$         |
|                |  | - AC (f > 1 Hz)                            | $\pm 30$         |
| $I_D$          | Drain Current  | - Continuous ( $T_C = 25^\circ\text{C}$ )  | 2.0              |
|                |  | - Continuous ( $T_C = 100^\circ\text{C}$ ) | 1.2              |
| $I_{DM}$       | Drain Current  | - Pulsed (Note 1)                          | 4.0              |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                              | 12.8                                       | mJ               |
| $I_{AR}$       | Avalanche Current (Note 1)   | 0.4  | A                |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)                                 | 0.32                                       | mJ               |
| dv/dt          | MOSFET dv/dt   | 100  | V/ns             |
|                | Peak Diode Recovery dv/dt (Note 3)                                   | 20   |                  |
| $P_D$          | Power Dissipation  | ( $T_C = 25^\circ\text{C}$ )               | 32               |
|                |  | - Derate Above $25^\circ\text{C}$          | 0.26             |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                              | -55 to +150                                | $^\circ\text{C}$ |
| $T_L$          | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds | 300  | $^\circ\text{C}$ |

### Thermal Characteristics

| Symbol          | Parameter                                     | FCD3400N80Z<br>FCU3400N80Z | Unit                      |
|-----------------|---|----------------------------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max.    | 3.9                        | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 62.5                       |                           |

FCD3400N80Z / FCU3400N80Z — N-Channel SuperFET<sup>®</sup> II MOSFET

## Package Marking and Ordering Information

| Part Number | Top Mark   | Package | Packing Method | Reel Size | Tape Width | Quantity   |
|-------------|------------|---------|----------------|-----------|------------|------------|
| FCD3400N80Z | FCD340080Z | DPAK    | Tape and Reel  | 330 mm    | 16 mm      | 2500 units |
| FCU3400N80Z | FCU340080Z | IPAK    | Tube           | N/A       | N/A        | 75 units   |

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted.

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|-----------------|------|------|------|------|
|--------|-----------|-----------------|------|------|------|------|

### Off Characteristics

|                                |   |   |     |     |          |                     |
|--------------------------------|---|---|-----|-----|----------|---------------------|
| $BV_{DSS}$                     | Drain to Source Breakdown Voltage         | $V_{GS} = 0\text{ V}, I_D = 1\text{ mA}, T_J = 25^\circ\text{C}$      | 800 | -   | -        | V                   |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 1\text{ mA}$ , Referenced to $25^\circ\text{C}$                | -   | 0.9 | -        | V/ $^\circ\text{C}$ |
| $I_{DSS}$                      | Zero Gate Voltage Drain Current           | $V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$                          | -   | -   | 25       | $\mu\text{A}$       |
|                                |   | $V_{DS} = 640\text{ V}, V_{GS} = 0\text{ V}, T_C = 125^\circ\text{C}$ | -   | -   | 250      |                     |
| $I_{GSS}$                      | Gate to Body Leakage Current              | $V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$                       | -   | -   | $\pm 10$ | $\mu\text{A}$       |

### On Characteristics

|              |                                      |  |     |      |     |          |
|--------------|--------------------------------------|--|-----|------|-----|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage               | $V_{GS} = V_{DS}, I_D = 0.2\text{ mA}$   | 2.5 | -    | 4.5 | V        |
| $R_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS} = 10\text{ V}, I_D = 1\text{ A}$ | -   | 2.75 | 3.4 | $\Omega$ |
| $g_{FS}$     | Forward Transconductance             | $V_{DS} = 20\text{ V}, I_D = 1\text{ A}$ | -   | 2    | -   | S        |

### Dynamic Characteristics

|                 |                               |   |   |      |     |          |
|-----------------|-------------------------------|---|---|------|-----|----------|
| $C_{iss}$       | Input Capacitance             | $V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$              | - | 299  | 400 | pF       |
| $C_{oss}$       | Output Capacitance            |   | - | 12.7 | 15  | pF       |
| $C_{rss}$       | Reverse Transfer Capacitance  |   | - | 0.36 | -   | pF       |
| $C_{oss}$       | Output Capacitance            | $V_{DS} = 480\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$              | - | 6.2  | -   | pF       |
| $C_{oss(eff.)}$ | Effective Output Capacitance  | $V_{DS} = 0\text{ V to } 480\text{ V}, V_{GS} = 0\text{ V}$                 | - | 41   | -   | pF       |
| $Q_{g(tot)}$    | Total Gate Charge at 10V      | $V_{DS} = 640\text{ V}, I_D = 2\text{ A}, V_{GS} = 10\text{ V}$<br>(Note 4) | - | 7.4  | 9.6 | nC       |
| $Q_{gs}$        | Gate to Source Gate Charge    |   | - | 1.6  | -   | nC       |
| $Q_{gd}$        | Gate to Drain "Miller" Charge |   | - | 3.1  | -   | nC       |
| ESR             | Equivalent Series Resistance  | $f = 1\text{ MHz}$  | - | 3.2  | -   | $\Omega$ |

### Switching Characteristics

|              |                     |  |   |      |    |    |
|--------------|---------------------|--|---|------|----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 400\text{ V}, I_D = 2\text{ A}, V_{GS} = 10\text{ V}, R_g = 4.7\ \Omega$<br>(Note 4) | - | 10   | 30 | ns |
| $t_r$        | Turn-On Rise Time   |  | - | 6.4  | 23 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |  | - | 22.7 | 55 | ns |
| $t_f$        | Turn-Off Fall Time  |  | - | 14   | 38 | ns |

### Drain-Source Diode Characteristics

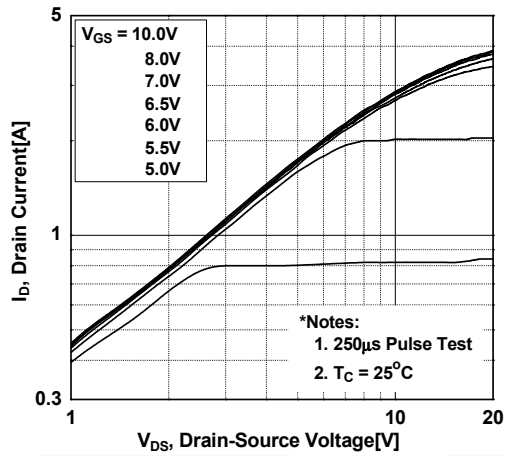
|          |  |  |   |     |     |    |
|----------|--|--|---|-----|-----|----|
| $I_S$    | Maximum Continuous Drain to Source Diode Forward Current | -  | - | 1.6 | A   |    |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current     | -  | - | 3.8 | A   |    |
| $V_{SD}$ | Drain to Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}, I_{SD} = 2\text{ A}$                                   | - | -   | 1.2 | V  |
| $t_{rr}$ | Reverse Recovery Time                                    | $V_{GS} = 0\text{ V}, I_{SD} = 2\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$ | - | 119 | -   | ns |
| $Q_{rr}$ | Reverse Recovery Charge                                  |  | - | 868 | -   | nC |

#### Notes:

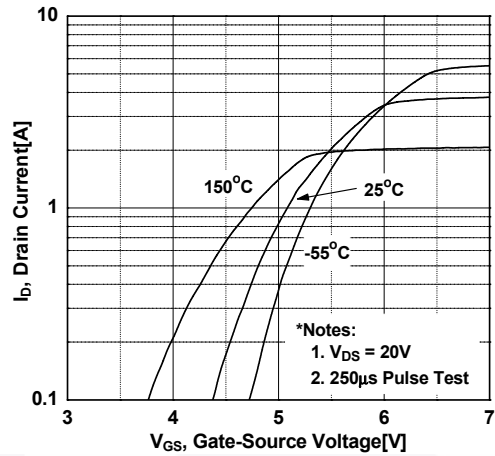
1. Repetitive rating: pulse width limited by maximum junction temperature.
2.  $I_{AS} = 0.4\text{ A}, R_G = 25\ \Omega$ , starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 2\text{ A}, di/dt \leq 200\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , starting  $T_J = 25^\circ\text{C}$
4. Essentially independent of operating temperature typical characteristic.

## Typical Performance Characteristics

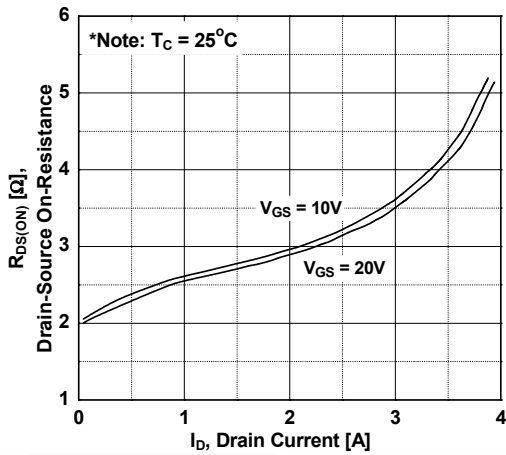
**Figure 1. On-Region Characteristics**



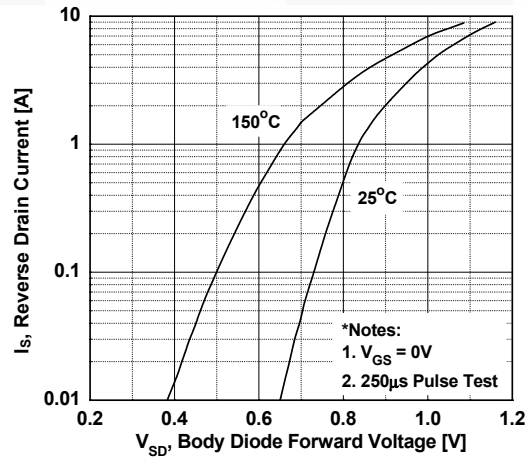
**Figure 2. Transfer Characteristics**



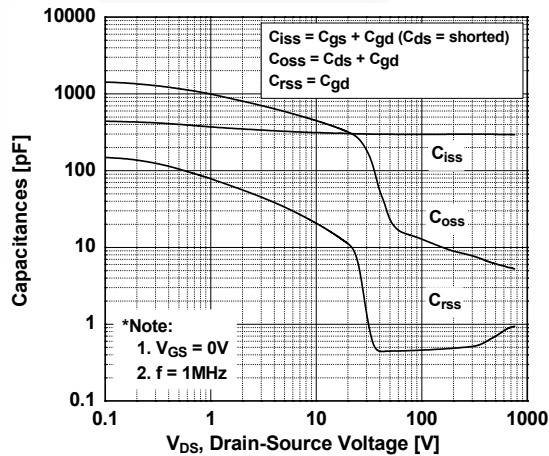
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



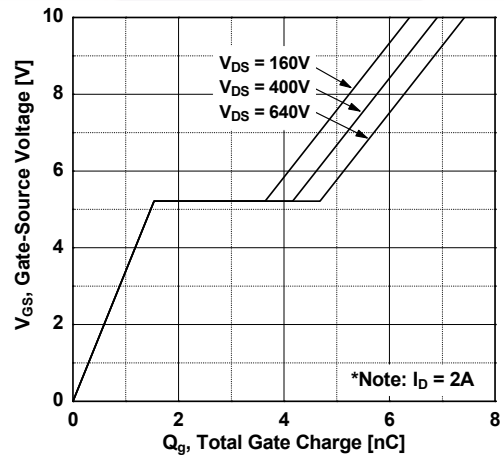
**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**



**Figure 5. Capacitance Characteristics**

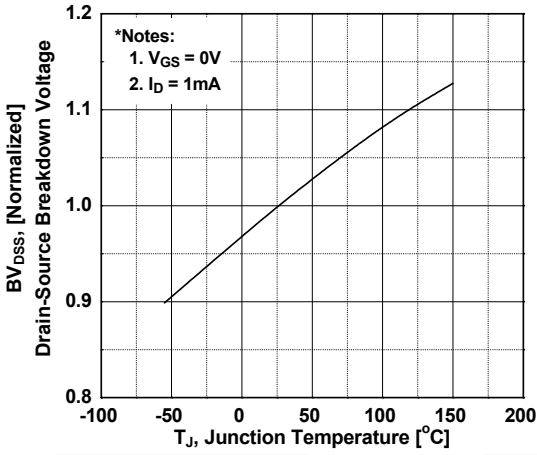


**Figure 6. Gate Charge Characteristics**

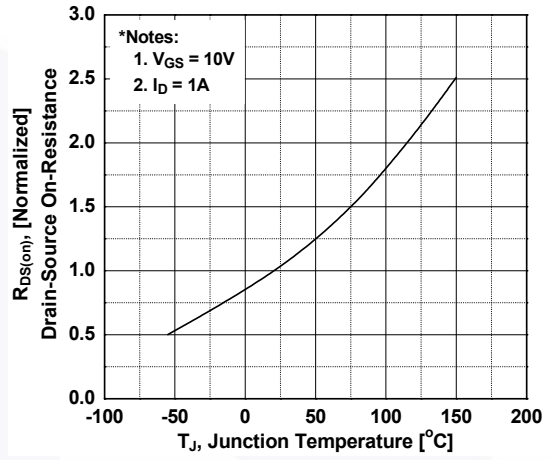


**Typical Performance Characteristics** (Continued)

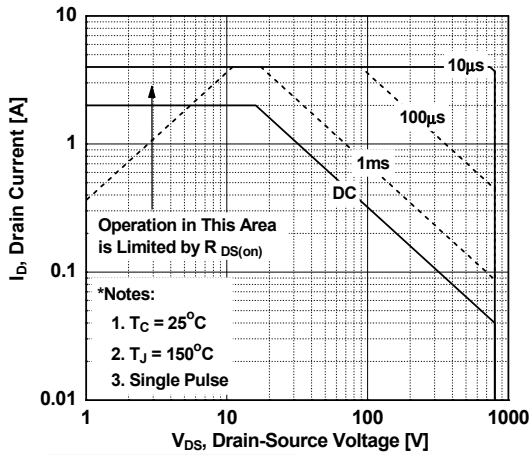
**Figure 7. Breakdown Voltage Variation vs. Temperature**



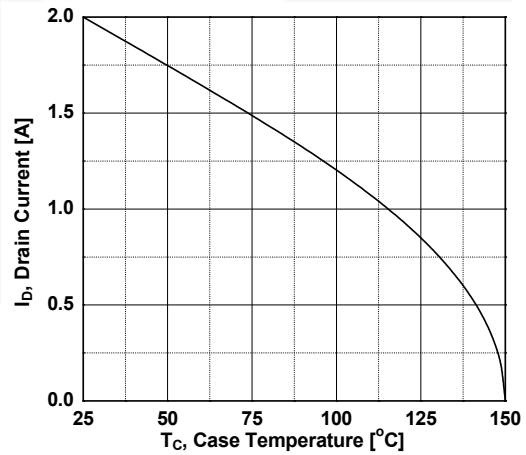
**Figure 8. On-Resistance Variation vs. Temperature**



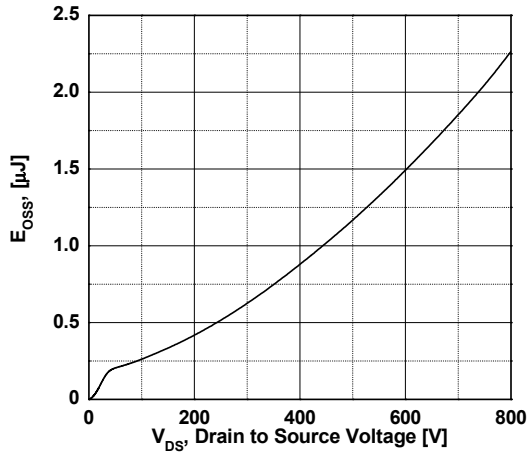
**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**

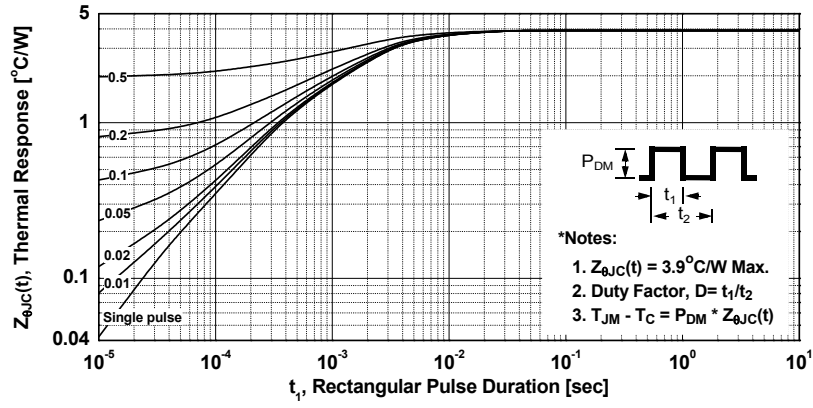


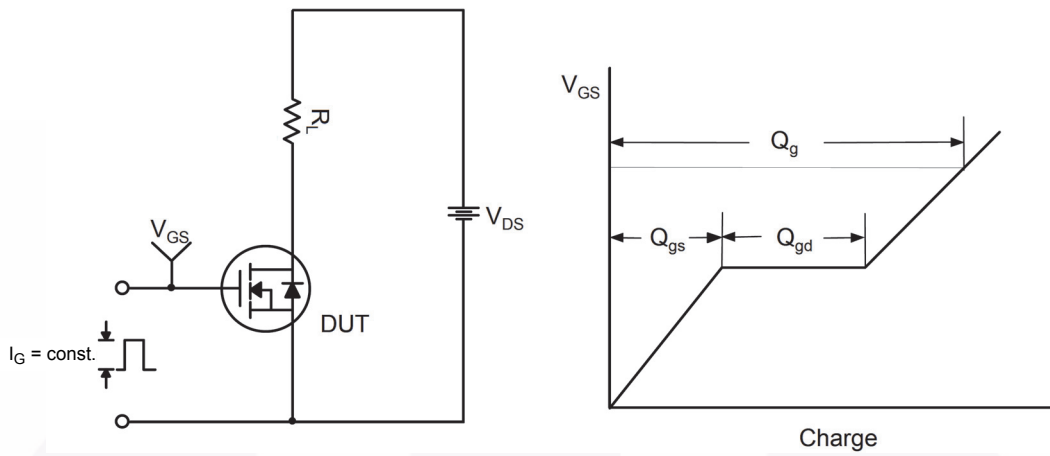
**Figure 11. E<sub>oss</sub> vs. Drain to Source Voltage**



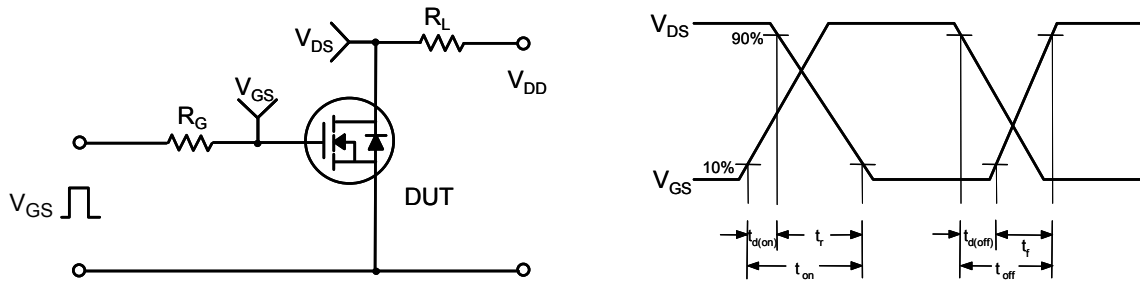
Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve

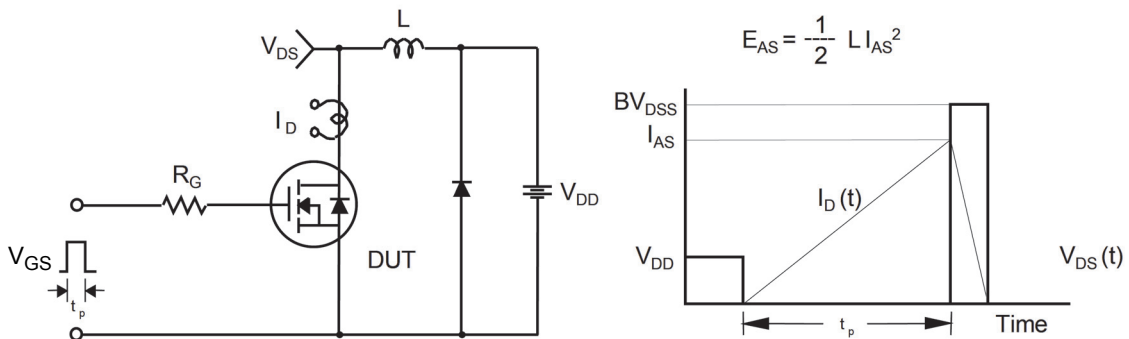




**Fig 13. Gate Charge Test Circuit & Waveform**



**Fig 14. Resistive Switching Test Circuit & Waveforms**



**Fig 15. Unclamped Inductive Switching Test Circuit & Waveforms**

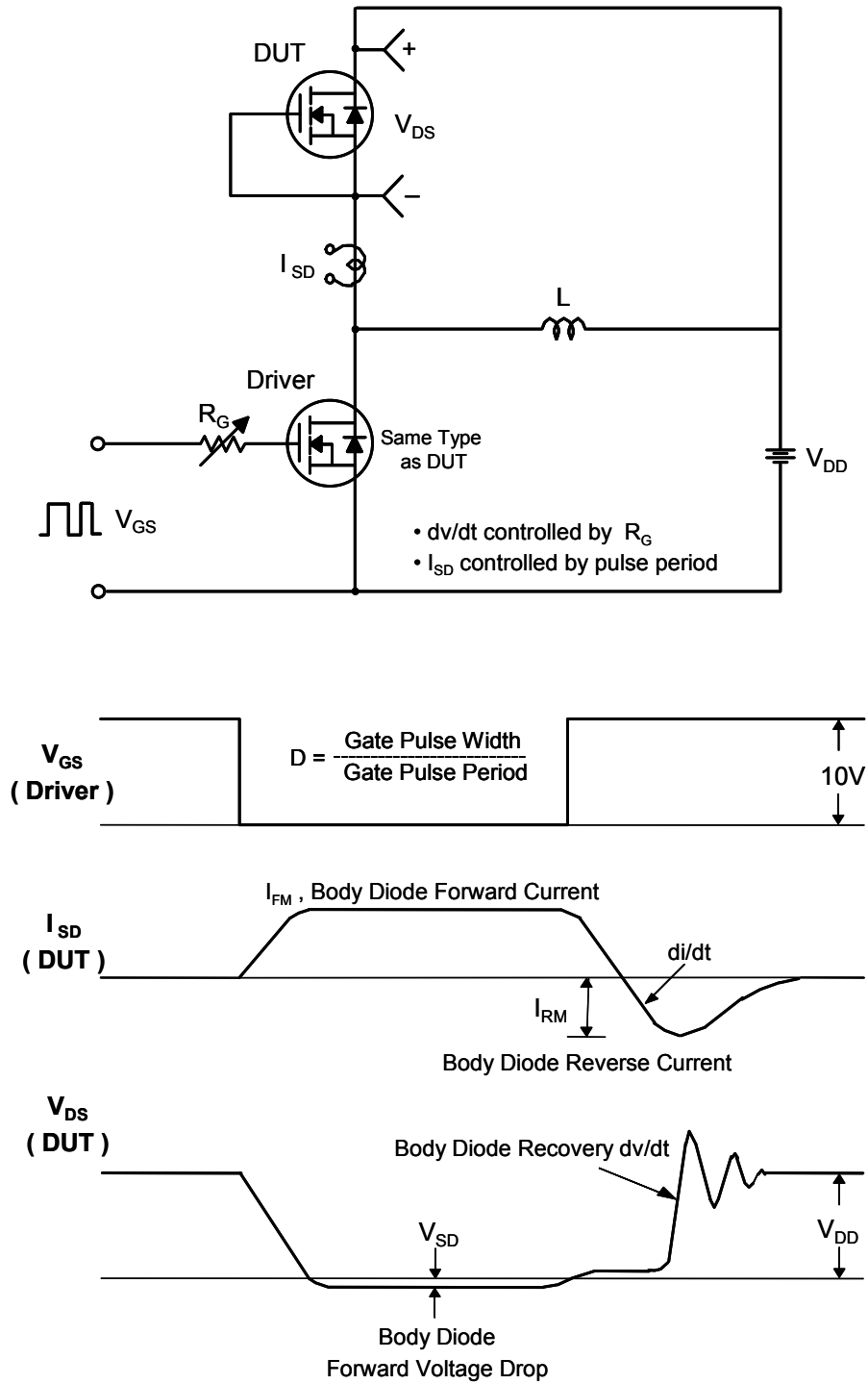
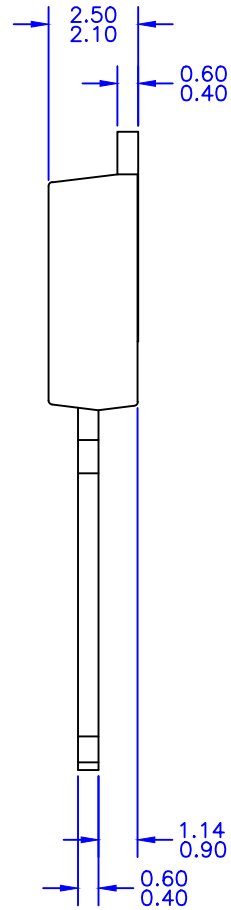
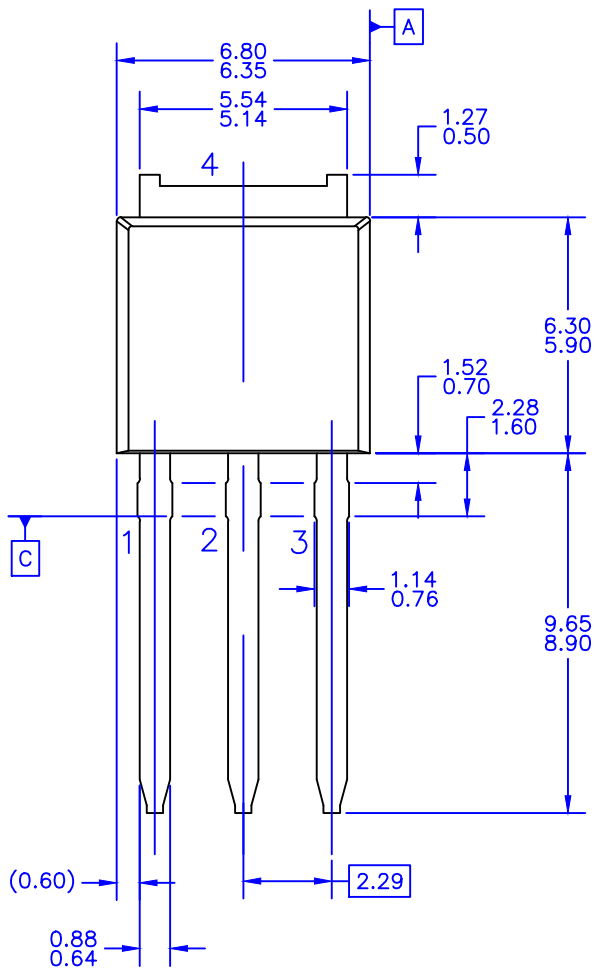
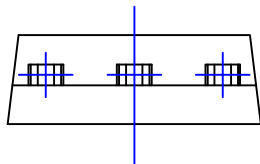


Fig 16. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms





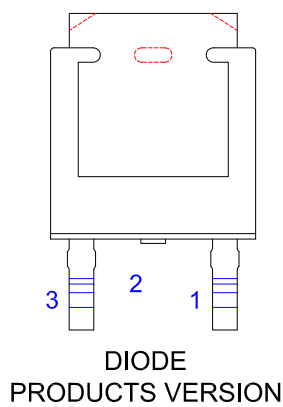
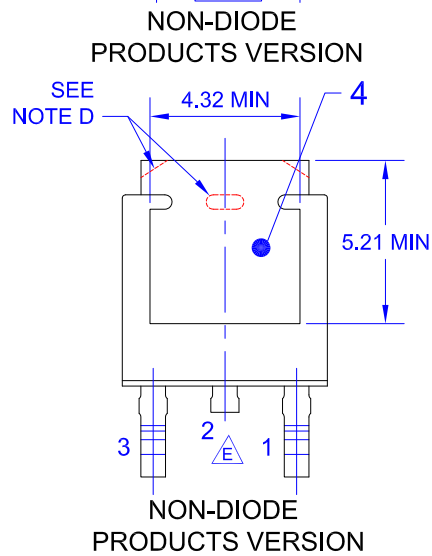
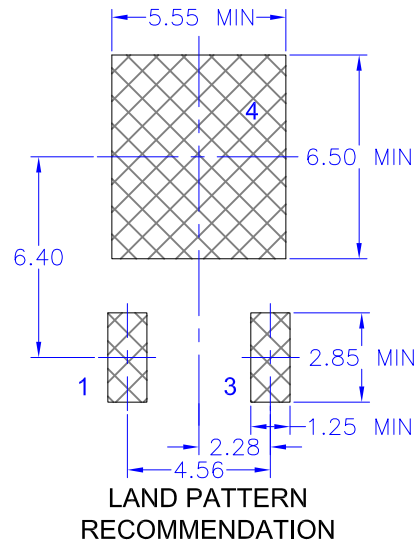
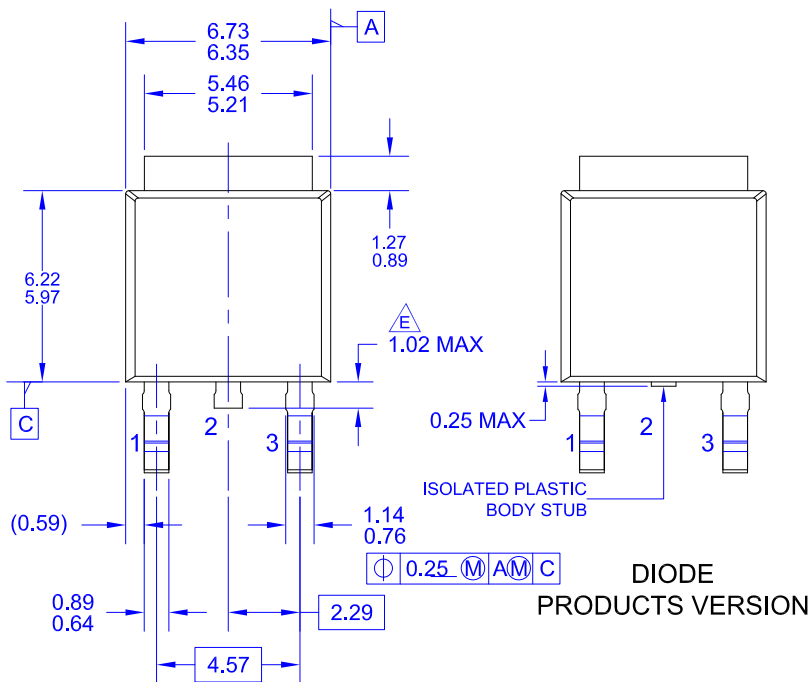
$\text{⌀} 0.25 \text{ (M)} \text{ (A)} \text{ (M)} \text{ (C)}$   
 3 PLCS



NOTES: UNLESS OTHERWISE SPECIFIED

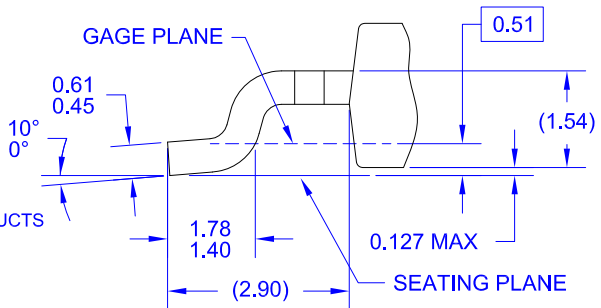
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